

Listing of Claims:

1. (Previously Presented): A method for in-phase and quadrature mismatch calibration of a transmitter, comprising the following steps:

generating a discrete-time signal $x[n] = x(n \cdot T_s)$, wherein $x(t) = e^{j2\pi f_T t}$ and

f_T and T_s are real numbers;

obtaining a corrected signal $x_c[n]$ based on the signal $x[n]$ and a set of

correction parameters A_p and B_p , wherein

$$x_c[n] = A_p \cdot x[n] + B_p \cdot x^*[n];$$

converting the corrected signal $x_c[n]$ to an analog corrected signal $x_c(t)$;

applying in-phase and quadrature modulation to the analog corrected signal $x_c(t)$ and outputting a modulated signal $x_m(t)$;

obtaining a first desired component measure $W^{(1)}(f_T)$ and a first image component measure $W^{(1)}(-f_T)$ from the modulated signal $x_m(t)$

with a first set of the correction parameters A_p and B_p ;

obtaining a second desired component measure $W^{(2)}(f_T)$ and a second image component measure $W^{(2)}(-f_T)$ from the modulated signal

$x_m(t)$ with a second set of the correction parameters A_p and B_p ;

obtaining a third desired component measure $W^{(3)}(f_T)$ and a third image component measure $W^{(3)}(-f_T)$ from the modulated signal $x_m(t)$

with a third set of the correction parameters A_p and B_p ;

obtaining a fourth and fifth set of correction parameters A_p and B_p based on the first, the second, and the third desired component

measures as well as the first, the second, and the third image component measures;

obtaining a fourth desired component measure $W^{(4)}(f_T)$ and a fourth image component measure $W^{(4)}(-f_T)$ from the modulated signal $x_m(t)$ with the fourth set of correction parameters A_p and B_p ;

obtaining a fifth desired component measure $W^{(5)}(f_T)$ and a fifth image component measure $W^{(5)}(-f_T)$ from the modulated signal $x_m(t)$ with the fifth set of correction parameters A_p and B_p ; and

obtaining a final set of the correction parameters A_p and B_p from the fourth and fifth sets of correction parameters.

2. (Previously Presented): The method for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 1, wherein the first set of correction parameters $(A_p, B_p) = (a, 0)$, the second set of correction parameters $(A_p, B_p) = (b, b)$, and the third set of correction parameters $(A_p, B_p) = (b, -b)$, where a and b are real numbers.

3. (Previously Presented): The method for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 2, wherein the parameter a is 1 and the parameter b is 1/2.

4. (Previously Presented): The method for mismatch calibration of a transmitter as claimed in claim 1, wherein the fourth set of correction parameters (A_p, B_p) are obtained by

$$\begin{aligned} A_p &= \sqrt{P} - j\hat{\alpha}\sqrt{Q} \\ B_p &= -\hat{\alpha}\sqrt{P} - j\sqrt{Q} \end{aligned}$$

and the fifth set of correction parameters (A_p, B_p) are obtained by

$$\begin{aligned} A_p &= \sqrt{P} + j\hat{\alpha}\sqrt{Q} \\ B_p &= -\hat{\alpha}\sqrt{P} + j\sqrt{Q} \end{aligned}$$

where

$$\alpha \approx \hat{\alpha} = \frac{\sqrt{N/O} - 1}{\sqrt{N/O} + 1},$$

$$N = (W^{(2)}(f_T) + W^{(2)}(-f_T)) / 2,$$

$$O = (W^{(3)}(f_T) + W^{(3)}(-f_T)) / 2,$$

$$Q = \frac{\hat{\alpha}^2 - \rho^{(1)}}{(1 + \rho^{(1)})(\hat{\alpha}^2 - 1)},$$

$$P = 1 - Q,$$

$$\rho^{(1)} = \frac{W^{(1)}(-f_T)}{W^{(1)}(f_T)}.$$

5. (Previously Presented): The method for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 1, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction parameters if a function of $W^{(4)}(-f_T)$ is less than the function of $W^{(5)}(-f_T)$,

otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

6. (Previously Presented): The method for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 5, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction parameters if a value of $W^{(4)}(-f_T)$ is less than a value of $W^{(5)}(-f_T)$, otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

7. (Previously Presented): The method for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 1, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction parameters if a function of $W^{(4)}(f_T)$ is greater than the function of $W^{(5)}(f_T)$, otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

8. (Previously Presented): The method for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 7, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction parameters if a value of $W^{(4)}(f_T)$ is greater than a value of $W^{(5)}(f_T)$, otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

9. (Previously Presented): The method for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 1, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction parameters if a function of $W^{(4)}(-f_T)$ and $W^{(4)}(f_T)$ is less than the function of $W^{(5)}(-f_T)$ and $W^{(5)}(f_T)$, otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

10. (Previously Presented): The method for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 9, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction parameters if $W^{(4)}(-f_T)/W^{(4)}(f_T)$ is less than $W^{(5)}(-f_T)/W^{(5)}(f_T)$, otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

11. (Previously Presented): The method for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 1, further comprising the following steps:

further adding a DC compensation parameter γ_p while obtaining the

corrected signal $x_c[n]$ such that

$$x_c[n] = A_p \cdot (x[n] + \gamma_p) + B_p \cdot (x[n] + \gamma_p)^* ;$$

obtaining a first local leakage component measure L_1 from the modulated signal $x_m(t)$ with the final set of parameters A_p and B_p , and the parameter $\gamma_p = \zeta_1$, where ζ_1 is a real number;

obtaining a second local leakage component measure L_2 from the modulated signal $x_m(t)$ with the final set of parameters A_p and B_p , and the parameter $\gamma_p = \zeta_2$, where ζ_2 is a real number;

obtaining a third local leakage component measure L_3 from the modulated signal $x_m(t)$ with the final set of parameters A_p and B_p , and the parameter $\gamma_p = j\zeta_1$;

obtaining a fourth local leakage component measure L_4 from the modulated signal $x_m(t)$ with the final set of parameters A_p and B_p , and the parameter $\gamma_p = j\zeta_2$;

obtaining a fifth local leakage component measure L_5 from the modulated signal $x_m(t)$ with the final set of parameters A_p and B_p , and the parameter $\gamma_p = 0$; and

obtaining a final DC compensation parameter $\gamma_{p,final}$ based on the first local leakage component measure L_1 , the second local leakage component measure L_2 , the third local leakage component measure L_3 , the fourth local leakage component measure L_4 and the fifth local leakage component measure L_5 .

12. (Previously Presented): The method for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 11, wherein the final DC compensation parameter $\gamma_{p,final}$ is obtained by

$$\gamma_{p,final} = -\frac{1}{2} \cdot \frac{\zeta_2^2(L_1 - L_5) - \zeta_1^2(L_2 - L_5)}{\zeta_1(L_2 - L_5) - \zeta_2(L_1 - L_5)} - j \frac{1}{2} \cdot \frac{\zeta_2^2(L_3 - L_5) - \zeta_1^2(L_4 - L_5)}{\zeta_1(L_4 - L_5) - \zeta_2(L_3 - L_5)}.$$

13. (Previously Presented): An apparatus for in-phase and quadrature mismatch calibration of a transmitter, comprising:

a signal generator for generating a discrete-time signal $x[n] = x(n \cdot T_s)$,

wherein $x(t) = e^{j2\pi f_T t}$ and f_T and T_s are real numbers;

a correction module for receiving the discrete-time signal $x[n]$ and

obtaining a corrected signal $x_c[n]$ based on the signal $x[n]$ and a

set of correction parameters A_p and B_p , wherein

$$x_c[n] = A_p \cdot x[n] + B_p \cdot x^*[n];$$

a first and second D/A converter converting the corrected signal $x_c[n]$ to

an analog signal $x_c(t)$, wherein the first D/A converter converts

the real part of the corrected signal to a real part of the analog

signal, and the second D/A converter converts the imaginary part

of the corrected signal to an imaginary part of the analog signal;

a modulator applying in-phase and quadrature modulation to the analog

signal $x_c(t)$, and outputting a modulated signal $x_m(t)$;

a measurer configured to:

obtain a first desired component measure $W^{(1)}(f_T)$ and a first image component measure $W^{(1)}(-f_T)$ from the modulated signal $x_m(t)$ with a first set of the correction parameters A_p and B_p ;

obtain a second desired component measure $W^{(2)}(f_T)$ and a second image component measure $W^{(2)}(-f_T)$ from the modulated signal $x_m(t)$ with a second set of the correction parameters A_p and B_p ;

obtain a third desired component measure $W^{(3)}(f_T)$ and a third image component measure $W^{(3)}(-f_T)$ from the modulated signal $x_m(t)$ with a third set of the correction parameters A_p and B_p ;

obtain a fourth desired component measure $W^{(4)}(f_T)$ and a fourth image component measure $W^{(4)}(-f_T)$ from the modulated signal $x_m(t)$ with a fourth set of correction parameters A_p and B_p ; and

obtain a fifth desired component measure $W^{(5)}(f_T)$ and a fifth image component measure $W^{(5)}(-f_T)$ from the modulated signal $x_m(t)$ with a fifth set of correction parameters A_p and B_p ; and

a processor configured to:

obtain the fourth and fifth sets of correction parameters A_p and B_p based on the first, the second, and the third desired component measures as well as the first, the second, and the third image component measures; and choose a final set of correction parameters A_p and B_p from the fourth and fifth sets of correction parameters.

14. (Previously Presented): The apparatus for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 13, wherein the first set of correction parameters $(A_p, B_p) = (a, 0)$, the second set of correction parameters $(A_p, B_p) = (b, b)$, and the third set of correction parameters $(A_p, B_p) = (b, -b)$, where a and b are real numbers.

15. (Previously Presented): The apparatus for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 14, wherein the parameter a is 1 and the parameter b is 1/2.

16. (Previously Presented): The apparatus for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 13, wherein the fourth set of correction parameters (A_p, B_p) are obtained by

$$\begin{aligned} A_p &= \sqrt{P} - j\hat{\alpha}\sqrt{Q} \\ B_p &= -\hat{\alpha}\sqrt{P} - j\sqrt{Q} \end{aligned}$$

and the fifth set of correction parameters (A_p, B_p) are obtained by

$$A_p = \sqrt{P} + j\hat{\alpha}\sqrt{Q}$$

$$B_p = -\hat{\alpha}\sqrt{P} + j\sqrt{Q}$$

where

$$\alpha \approx \hat{\alpha} = \frac{\sqrt{N/O} - 1}{\sqrt{N/O} + 1},$$

$$N = (W^{(2)}(f_T) + W^{(2)}(-f_T)) / 2,$$

$$O = (W^{(3)}(f_T) + W^{(3)}(-f_T)) / 2,$$

$$Q = \frac{\hat{\alpha}^2 - \rho^{(1)}}{(1 + \rho^{(1)})(\hat{\alpha}^2 - 1)},$$

$$P = 1 - Q,$$

$$\rho^{(1)} = \frac{W^{(1)}(-f_T)}{W^{(1)}(f_T)}.$$

17. (Previously Presented): The apparatus for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 13, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction parameters if a function of $W^{(4)}(-f_T)$ is less than the function of $W^{(5)}(-f_T)$, otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

18. (Previously Presented): The apparatus for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 17, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction

parameters if a value of $W^{(4)}(-f_T)$ is less than a value of $W^{(5)}(-f_T)$, otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

19. (Previously Presented): The apparatus for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 13, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction parameters if a function of $W^{(4)}(f_T)$ is greater than the function of $W^{(5)}(f_T)$, otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

20. (Previously Presented): The apparatus for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 19, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction parameters if a value of $W^{(4)}(f_T)$ is greater than a value of $W^{(5)}(f_T)$, otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

21. (Previously Presented): The apparatus for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 13, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction parameters if a function of $W^{(4)}(-f_T)$ and $W^{(4)}(f_T)$ is less than the function of

$W^{(5)}(-f_T)$ and $W^{(5)}(f_T)$, otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

22. (Previously Presented): The apparatus for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 21, wherein the final set of correction parameters (A_p, B_p) is set to be the fourth set of correction parameters if $W^{(4)}(-f_T)/W^{(4)}(f_T)$ is less than $W^{(5)}(-f_T)/W^{(5)}(f_T)$, otherwise the final set of correction parameters (A_p, B_p) is set to be the fifth set of correction parameters.

23. (Previously Presented): The apparatus for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 13, wherein the processor further configured to:

further add a DC compensation parameter γ_p while obtaining the

corrected signal $x_c[n]$ such that

$$x_c[n] = A_p \cdot (x[n] + \gamma_p) + B_p \cdot (x[n] + \gamma_p)^* ;$$

obtain a first local leakage component measure L_1 from the modulated signal $x_m(t)$ with the final set of parameters A_p and B_p , and the parameter $\gamma_p = \zeta_1$, where ζ_1 is a real number;

obtain a second local leakage component measure L_2 from the modulated signal $x_m(t)$ with the final set of parameters A_p and B_p , and the parameter $\gamma_p = \zeta_2$, where ζ_2 is a real number;

obtain a third local leakage component measure L_3 from the modulated signal $x_m(t)$ with the final set of parameters A_p and B_p , and the parameter $\gamma_p = j\zeta_1$;

obtain a fourth local leakage component measure L_4 from the modulated signal $x_m(t)$ with the final set of parameters A_p and B_p , and the parameter $\gamma_p = j\zeta_2$;

obtain a fifth local leakage component measure L_5 from the modulated signal $x_m(t)$ with the final set of parameters A_p and B_p , and the parameter $\gamma_p = 0$; and

obtain a final DC compensation parameter $\gamma_{p,final}$ based on the first local leakage component measure L_1 , the second local leakage component measure L_2 , the third local leakage component measure L_3 , the fourth local leakage component measure L_4 and the fifth local leakage component measure L_5 .

24. (Previously Presented): The apparatus for in-phase and quadrature mismatch calibration of a transmitter as claimed in claim 23, wherein the final DC compensation parameter $\gamma_{p,final}$ is obtained by

$$\gamma_{p,final} = -\frac{1}{2} \cdot \frac{\zeta_2^2(L_1 - L_5) - \zeta_1^2(L_2 - L_5)}{\zeta_1(L_2 - L_5) - \zeta_2(L_1 - L_5)} - j \frac{1}{2} \cdot \frac{\zeta_2^2(L_3 - L_5) - \zeta_1^2(L_4 - L_5)}{\zeta_1(L_4 - L_5) - \zeta_2(L_3 - L_5)}.$$